

Contribution ID: 287 Type: Parallel

## Measurements of photon-induced processes with the CMS detector

Thursday 10 July 2025 08:30 (20 minutes)

Measurements of photon-induced processes are presented, using data collected in Run-2.

## Secondary track

T06 - Top and Electroweak Physics

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Presenter: HE, Zongsheng

**Session Classification:** Joint T06+T08

Track Classification: T06 - Top and Electroweak Physics